

Considerations for Selecting a PCB Surface Finish

AHOT IPC Designers Council Meeting October 8, 2013 Cheryl Tulkoff ctulkoff@dfrsolutions.com

Importance of SF

- The selection of the surface finish on your PCBs could be the most important material decision made for the electronic assembly.
- The surface finish influences the process yield, the amount of rework, field failure rate, the ability to test, the scrap rate, and of course the cost.
- One can be lead astray by selecting the lowest cost surface finish only to find that the eventual total cost is much higher.
- The selection of a surface finish should be done with a holistic approach that considers all important aspects of the assembly.

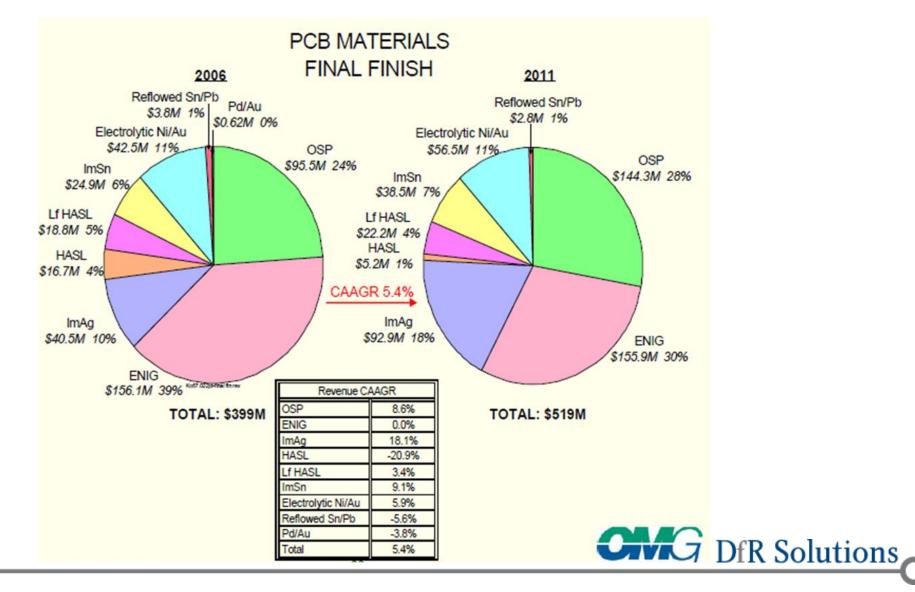
Surface Finishes - Post Pb-Free

- Multiple Pb-Free Surface Finish Options Now Exists.
 - No clear winner, no ideal solution.
- Each PCB surface has different advantages and disadvantages that affects fabrication, solderability, testability, reliability, or shelf life.

• The 5 most popular Pb-Free Surface Finishes are:

- Electroless nickel/immersion gold (ENIG)
 - And ENEPIG (electroless Pd added)
- Immersion silver (ImAg)
- Immersion tin (ImSn)
- Organic solderability preservative (OSP)
- Pb-free HASL.
- These finishes (except for Pb-free HASL) have been in use for several years.
- Newer finishes are currently being developed (direct Pd, PTFE-like coatings, nanofinishes)

Surface Finishes - Post Pb-Free



What is your SF selection approach?

- Component Procurement: Select the cheapest one and let the engineers figure out how to use it.
- PCB Engineer: Select the finish that is easiest for the suppliers to provide (their sweet spot); let the assembler figure out how to use it.
- Assembly Engineer: Select the finish that provides the largest process window for assembly and test.
- Sustaining Engineer: Select the finish that minimizes field failures.

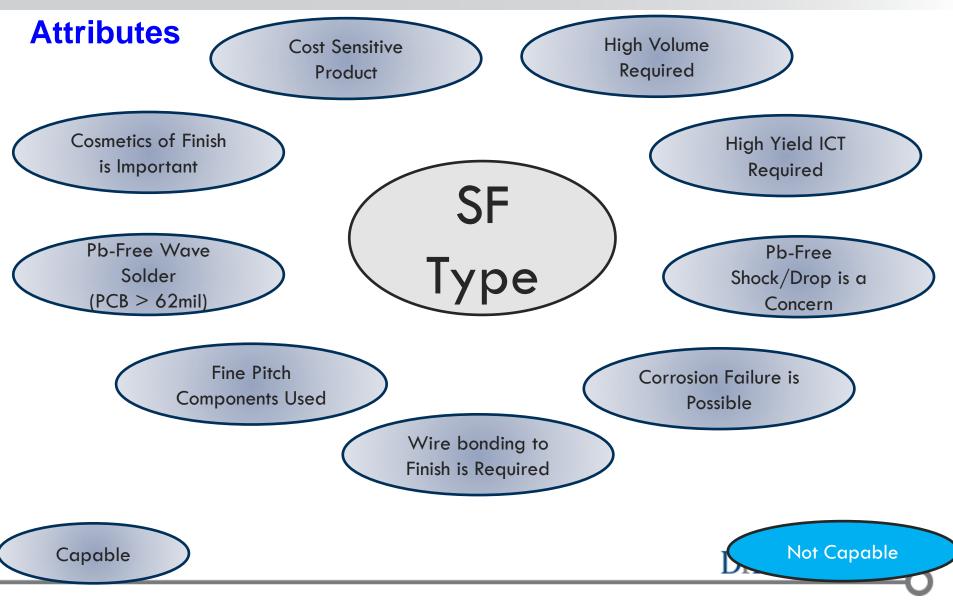
DfR Solutions

• **CEO**: Select the finish that minimizes the overall cost (including reliability risk).

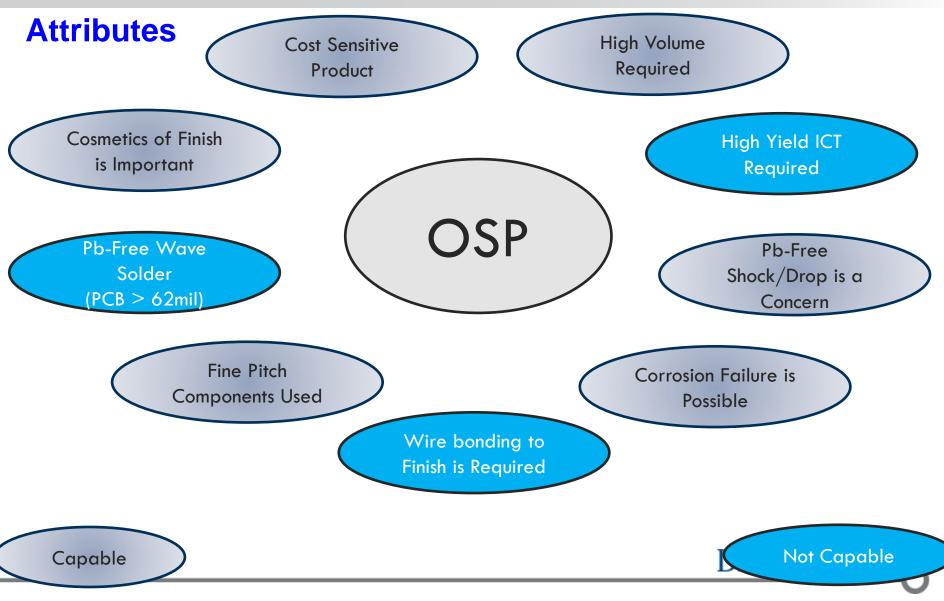
Considerations with SF Selection

- Cost sensitivity
- Volume of product (finish availability)
- SnPb or LF process
- o Shock/Drop a concern?
- High yield ICT is important
- o Is direct wire bonding required?
- User environment (corrosion a concern)?
- Fine pitch assembly (<0.5 mm)
- Wave solder required (PCB > 0.062")
- Are cosmetics of the PCB a concern?

Surface Finish Selection Guideline

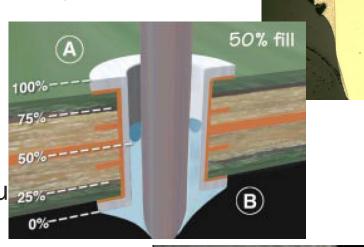


Surface Finish Selection Guideline



OSP Issues: Plated Through-Hole Fill

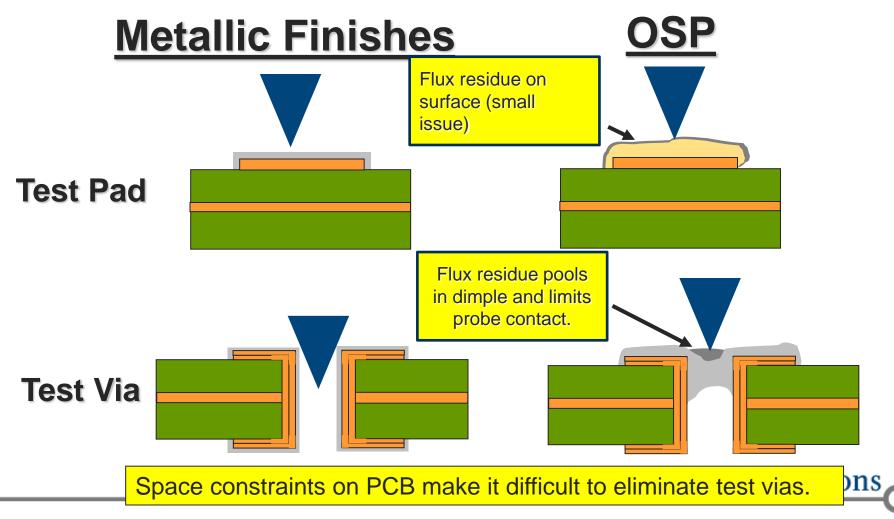
- Solder fill is driven by capillary action
- Important parameters
 - Hole diameter, hole aspect ratio, wetting force
 - Solder will only fill as long as its molten (key point)
- OSP has lower wetting force
 - Risk of insufficient hole fill
 - Can lead to single-sided architectu 25%
- Solutions:
 - Changing board solderability plating
 - Increasing top-side preheat
 - Increasing solder pot temperature (some go as high as 280°C)
 - Not recommended!
 - Changing your wave solder alloy



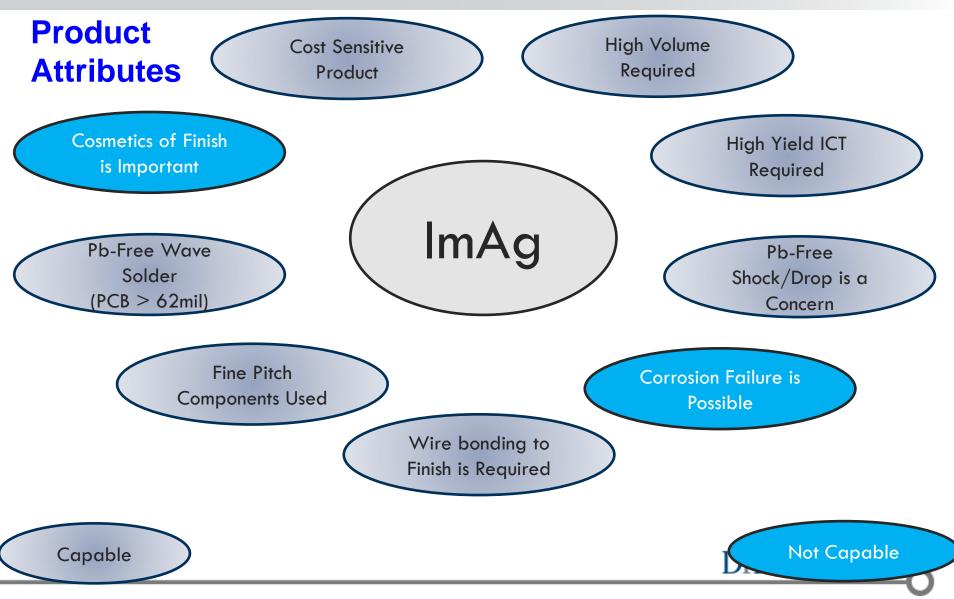


In Circuit Test w/ OSP – test via challenges

- Probing through HT OSP is not recommended.
- Solder paste is printed over OSP test pads/vias (leaving flux residue with no-clean paste).



Surface Finish Selection Guideline

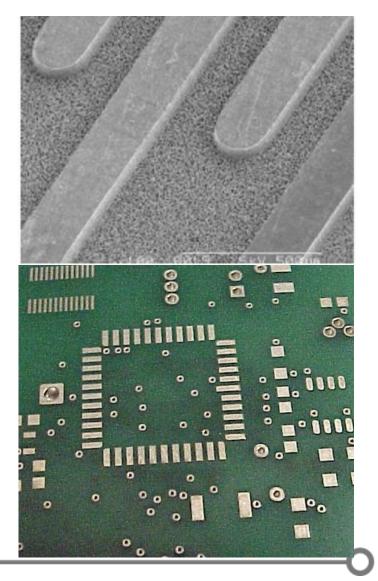


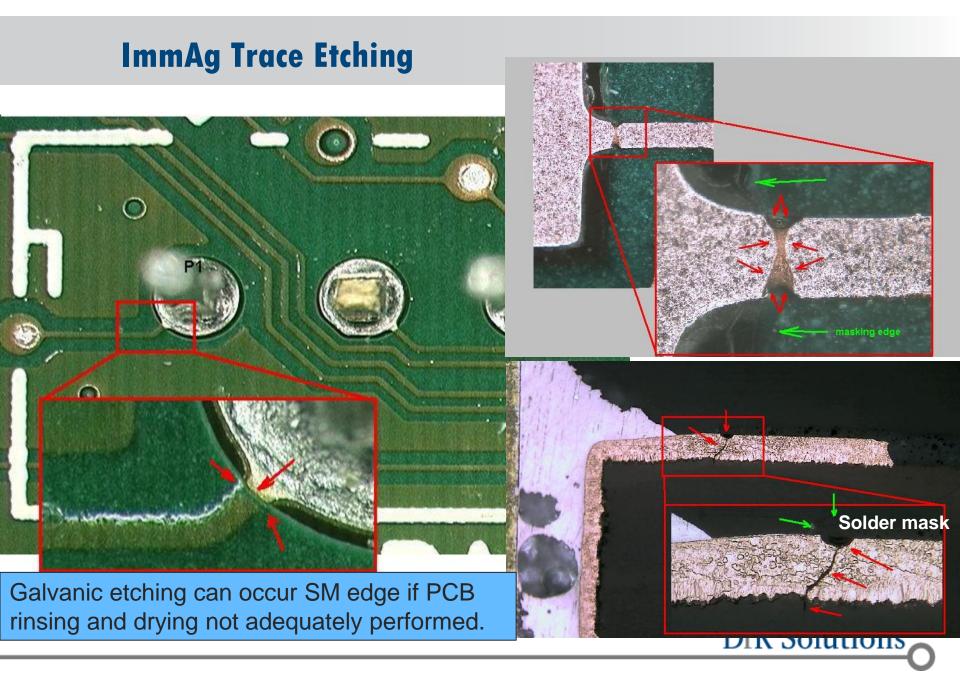
Immersion Silver Ag (ImAg)

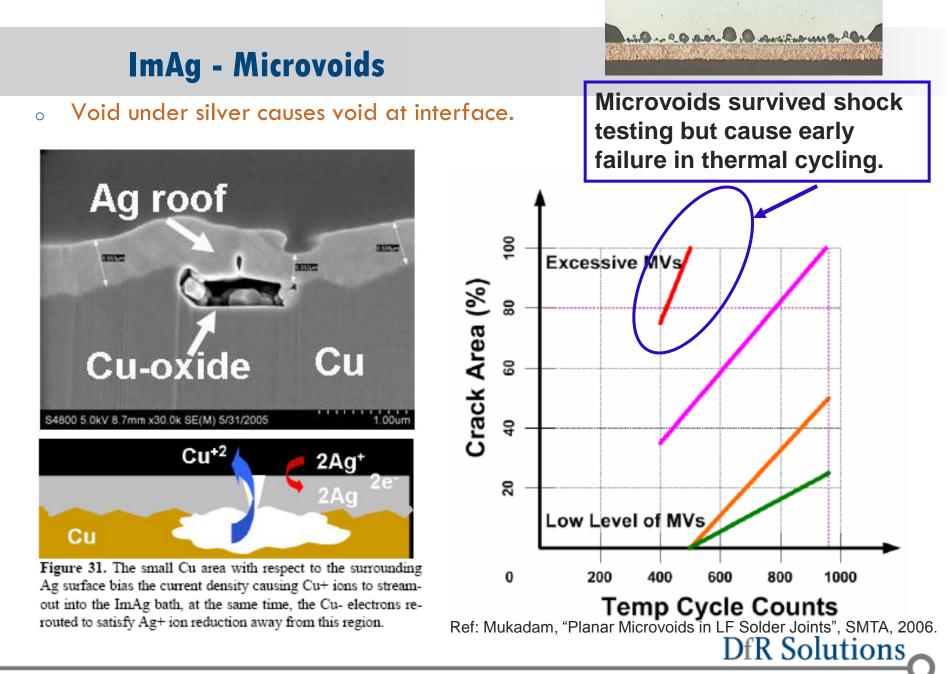
- Single material system
 Specified by IPC-4553
- Thickness is typically 6-20 u"

Benefits

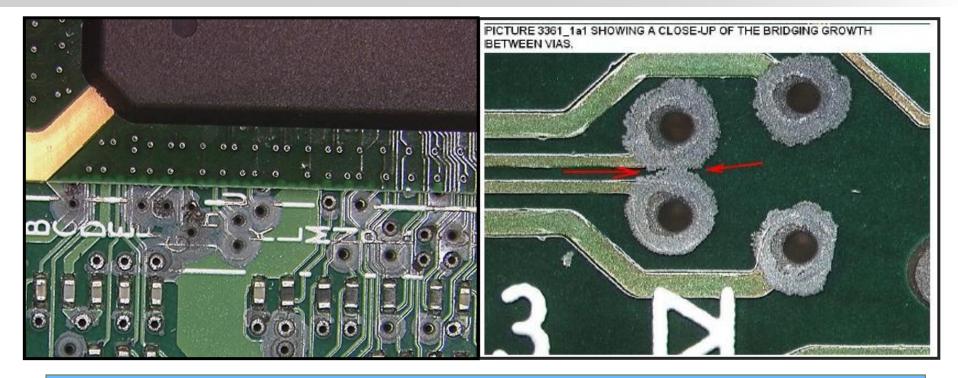
- Good flatness & coplanarity
- Good shelf life if packaged properly.
- Good oxidation resistance & shelf life.
- Good wettability and reflow performance.
- Good testability
- Low cost







Typical Creep Corrosion



- Corrosion product is poorly conductive (resistance of about 1Mohm).
- Conductivity is higher when the humidity is high.
- Field returns often function fine since corrosion product has dried out.
- Features most sensitive to leakage current will trigger the system failure (failing symptoms can vary system-to-system).
- Visual inspection is often required to diagnose.

ImAg Creep Corrosion - Affected Locations

- Paper mills
- Rubber manufacturing (tires for example).
- Fertilizer
- Waste water treatment
- Mining/smelting
- Cement or asphalt production
- Petrochemical
- Clay modeling studios
- Regions of the world with poor air quality
- Etc. includes companies nearby such industries

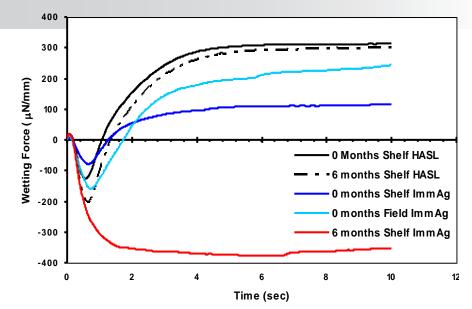
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• Product is less impacted if airflow to PCBA is restricted.



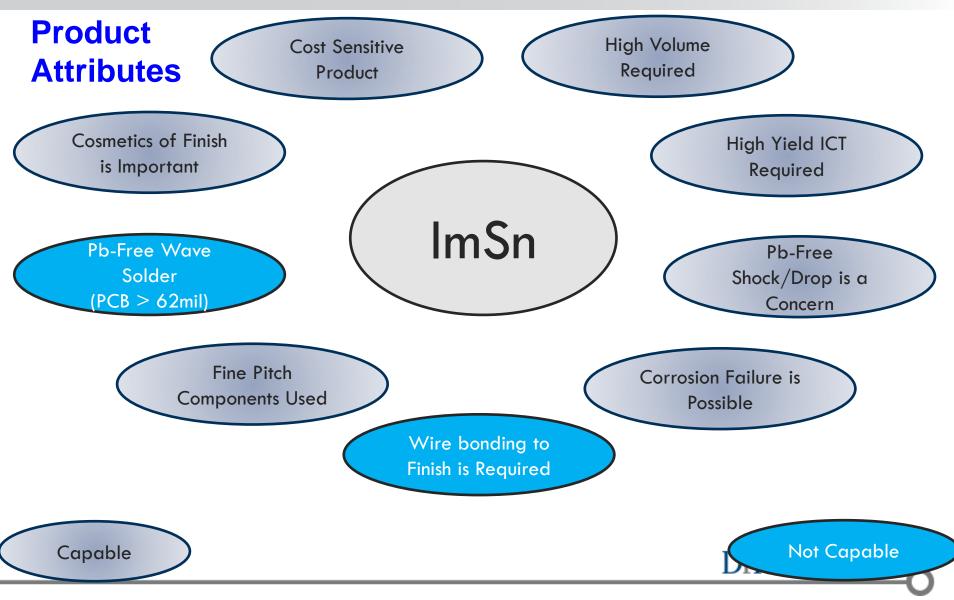
Impact of Tarnish

- Shelf life can be an issue
 - If not stored in protective bags
 - Significant degradation when exposed to corrosive gases



- Tarnish after assembly is mostly cosmetic but will impact perception of quality.
- If PCBA is visible to user tarnish may be an issue.
- Scrap costs may increase considerably if PCBAs are repaired and sent back into service.
 - Boards that appear black but are still functional are often thrown out.

Surface Finish Selection Guideline



Immersion Sn (ImSn)

- A single material system
 - Specified by IPC-4554
 - Standard thickness: 1 micron (40 microinches)
 - □ Some companies spec up to 1.5 microns (65 microinches)

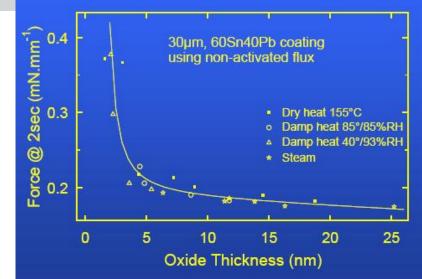
- Benefits
 - Excellent flatness, low cost
- Not as popular a choice with PCB fabricators.
 - Environmental and health concerns regarding thiourea (a known carcinogen)
 - Some concern regarding tin whiskering (minimal)

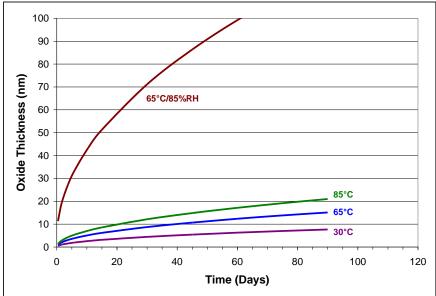


ImSn: Quality Issues & Failure Mechanisms

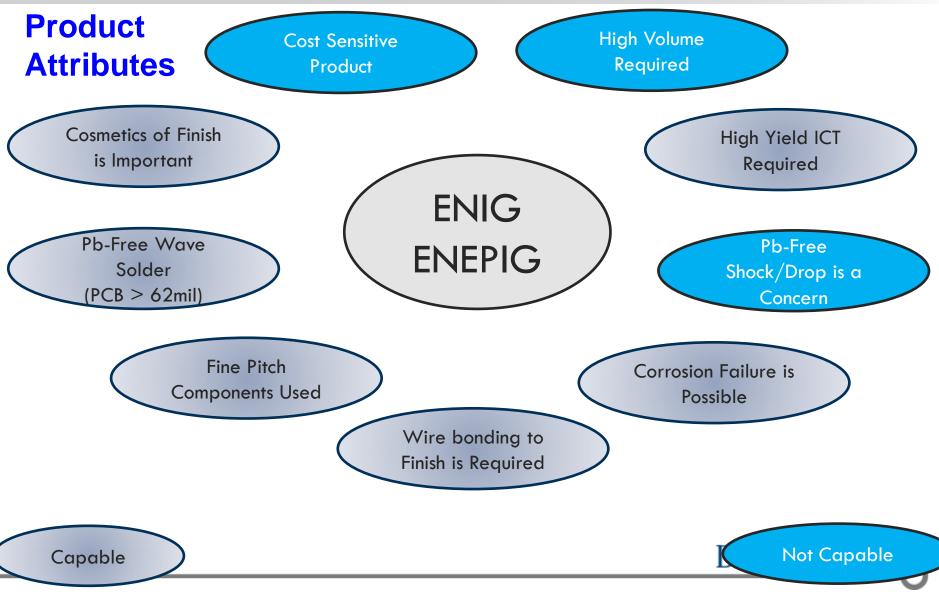
Insufficient thickness.

- Decreases solderability during storage or after 2nd reflow – due to IMC growth through the thickness.
- Solderability problems with Oxide thickness greater than 5 nm.
 - Excessive oxide thicknesses (50-100nm) periodically observed.
- Drivers of oxidation.
 - Exposure to humid conditions (>75%RH)
 - Greatly accelerates oxide growth through the creation of tin hydroxides.
 - Use sealed moisture/air tight wrapping for shipping and cool, low humidity storage.
 - Cleanliness of the raw board.
 - Contaminates breaks down selflimiting nature of tin oxides.
 - Accelerates oxide growth.



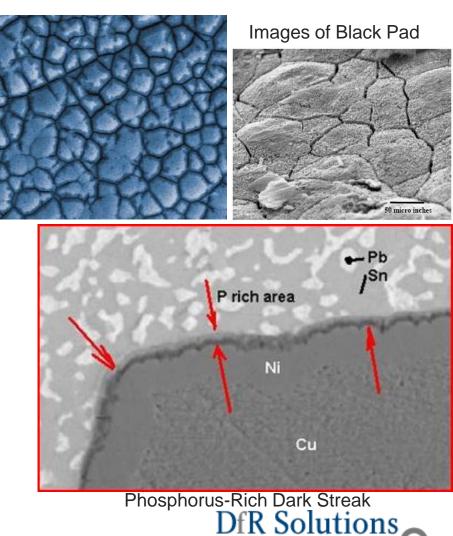


Surface Finish Selection Guideline

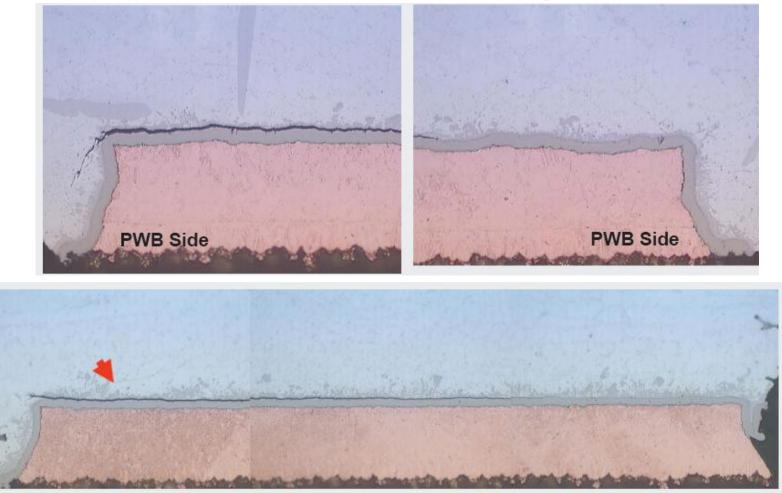


ENIG: Primary Reliability Risks

- Black pad drivers
 - Phosphorus content
 - High levels = weak, phosphorus-rich region after soldering
 - Low levels = hyper-corrosion (black pad) Insufficient Phosphorous will not prevent corrosion during the highly acidic immersion gold (IG) process.
 - Cleaning parameters
 - Gold plating parameters
 - Bond pad designs
- Causes a drop in mechanical strength
 - Difficult to screen
 - Can be random (e.g., 1 pad out of 300)
- Ni-Sn intermetallic produces a brittle interface when used with SAC solder.



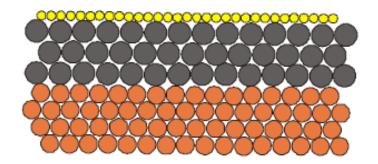
ENIG - Ni Interface Issues w/ SAC



Brittle SnNi intermetallics fail more easily with a high modulus LF solder ball. These cracks resulted from product handling.

Electroless Nickel/Immersion Gold (ENIG)

- Two material system.
 - Defined by IPC-4552 Specification for Electroless Nickel/Immersion Gold.
 - Electroless nickel.
 - □ 3 6 microns
 - Thin Immersion gold top coat
 - 0.08-0.23 microns

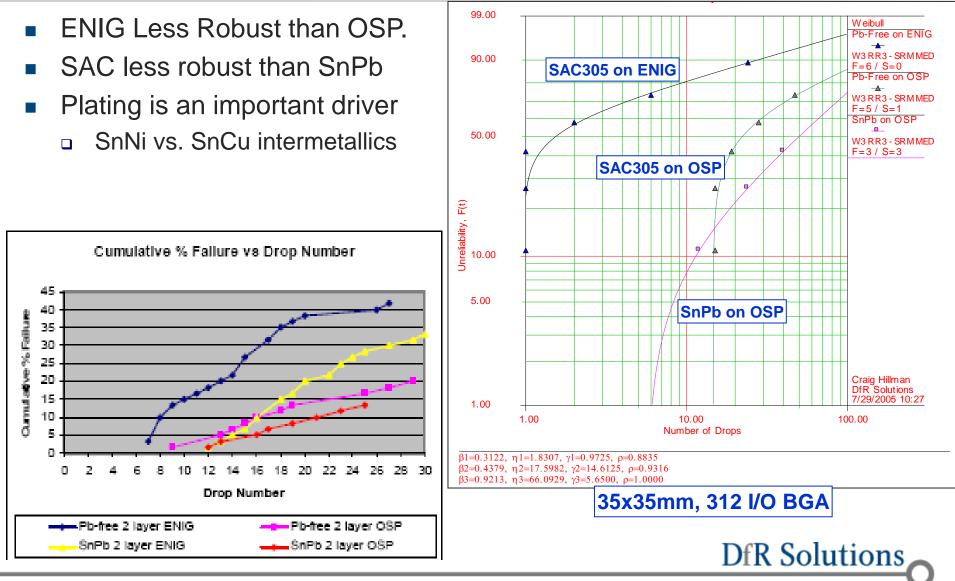


DfR Solutions

Benefits

- Excellent flatness and long-term storage (shelf life).
- Excellent oxidation resistance and wetting properties.
- Robust for multiple reflow cycles,
- Supports alternate connections (wirebond, separable connector) & electrical testability.
- Moderate costs.
- Gold readily dissolves into solder and does not tarnish or oxidize making it an excellent choice for a surface finish.
 - But gold cannot be directly plated onto copper, since copper diffuses into gold, which allows the Cu to reach the surface and oxidize which reduces solderability.
 - Nickel is serves as a barrier layer to copper, the thin gold coating protects the nickel from oxidizing.

ENIG: Mechanical Shock with SAC305 solder



Reliability Test Plan?

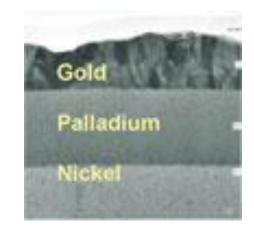
- It is the process of ensuring the product <u>design</u> and <u>manufacturing</u> process are sufficiently robust to provide the product <u>performance</u> and <u>lifetime</u> required by the <u>customer</u> in their use <u>environment</u>
- What does this mean?
 - Testing should not be performed on prototypes
 - Validate the Pb-free process before or as part of the product qualification
 - Relevant failure modes and their environmental stressors must be identified

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 Acceleration factors must be determined to calculate test parameters and length

ENEPIG

- Electroless nickel, electroless palladium, immersion gold
 - Initially aimed at IC packages and microelectronics
 - Most common lead finish after tin



Thicknesses

- □ Nickel: 5um / 200 µin (120-240)
- □ Palladium: 0.15um / 6 µin (2-15)
- □ Gold: 0.1 um / 4 µin (2 to 8)

Au	Min 0.05 🔎
Pd-p(3~7%)	0.05~0.2 µm
Ni-P(6~8%)	3~8 µm
Cu	Over 25 🔎
BASE	



ENEPIG Advantages

- Long-term storage (similar to ENIG)
- Solderable and wire bondable (unlike ENIG)
 - Gold and aluminum wire bonds
 - Traditional surface finishes would require ENIG (electroless nickel, immersion gold) over the SMT pads and an additional soft bondable gold over the wire bond pads.
 - Combined cost of ENIG and soft bondable gold process can be more than the higher raw material price of ENEPIG
- NO black pad (unlike ENIG)

ENEPIG Concerns

- Need to maintain control over palladium thickness
 - When used as lead finish, thick palladium can sometimes result in wetting issues
- Does not wet as well as HASL
- Not widely available
- More complex process
 - □ <u>Three</u> plating steps; violates keep it simple (KIS) principle

ENEPIG Concerns

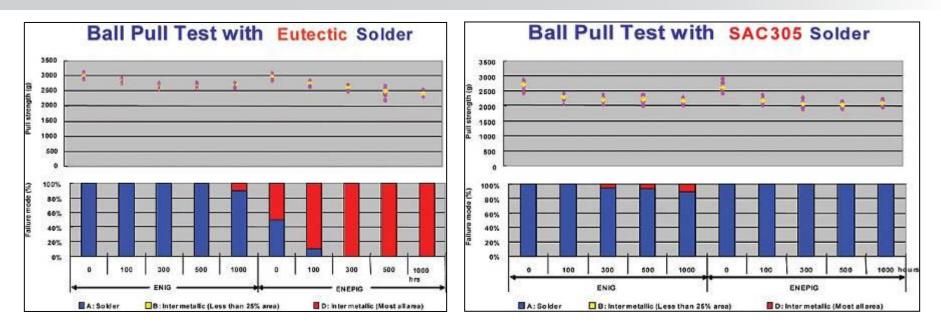
 Thick palladium can also result in decrease in solder joint strength (grams-force)

Au um									
Pd um	0.03	0.05	0.07	0.1	0.15	0.2	0.25	0.3	0.4
0.01	90	90	90	90	90	80	80	55	60
0.02	100	100	100	100	100	90	90	90	90
0.03	100	100	100	100	100	100	100	100	90
0.05	100	100	100	100	100	100	100	100	90
0.07	100	100	100	100	100	100	90	90	90
0.10	90	90	90	90	90	90	80	80	80
0.12	85	85	83	8	80	80	60	73	55
0.15	50	60	60	55	55	55	55	60	
0.20	50	60	50	55	58	60	30	35	30
0.30	20	45	40	30	20	30	20	30	30

Uyemura, G. Milad

DfR Solutions

ENEPIG (cont.)



- Shows embrittlement with SnPb
 - Lack of copper results in uneven dispersion of Pd in intermetallic layer
 - Copper necessary for stable IMC growth, strong bond (Cu,Ni/Sn+Pd)
 - □ Could be an issue with low-copper Pb-free alloys (i.e., SnBi)
- Bonding of SAC305 with nickel is still suspect
 - Consistency of Pd's influence has not been validated

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ENEPIG

- Gold thickness needs to be maintained for sufficient wire bond strength
 - Compatibility with copper uncertain

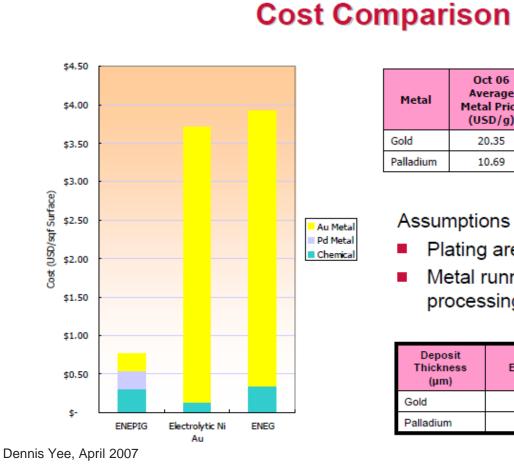
	Au um								
Pd um	0.03	0.05	0.07	0.1	0.15	0.2	0.25	0.3	0.4
0.00	0.00	4.3	4.4	3.9	3.8	3.7	5.1	8.6	9.1
0.01	6.8	7.9	7.9	8.1	8.7	8.6	9.6	10.6	10.5
0.02	6.7	7.9	8.6	8.2	8.5	9.0	9.5	10.2	10.7
0.03	6.0	7.7	8.4	8.2	8.2	9.3	9.3	10.7	10.4
0.05	6.8	7.6	8.9	8.1	8.2	9.1	9.3	10.1	10.6
0.07	7.0	7.8	8.1	8.3	8.8	9.5	9.1	10.9	11.1
0.10	6.0	6.7	8.1	8.3	8.4	9.3	9.2	10.0	10.8
0.12	7.2	8.4	8.9	8.8	8.9	9.5	9.6	10.9	10.5
0.15	6.5	8.5	8.6	8	9.1	9.4	10.2	10.3	10.7
0.20	6.0	8.8	8,9	8.7	9.1	9.4	10.0	10.3	10.5
0.30	6.6	8.8	8,5	8.3	9.0	9.6	10.0	10.2	10.6

Wire pull testing: Average of 20 wires (grams-force)

Direct Immersion Gold

- Combination immersion and electroless
 - Claims of pore-free gold surface
 - Normal immersion gold has trouble properly attaching to copper surface
- Developed specifically for parts where nickel could create RF interference.
- To avoid the inherent problems of copper migration through the thin gold surface, it is necessary for these parts to go to final assembly within four months
 Not widely used

Some Comparative Cost Information



ELECTRONIC MATERIALS

CIRCUIT BOARD TECHNOLOGIES

ROHM

HAAS

	Oct 06 Average	Density (g/cc)				
Metal	Metal Price (USD/g)	Metal	Electrolytic	Electroless		
Gold	20.35	19.30	19.00	19.00		
Palladium	10.69	12.00	11.90	10.00		

Assumptions

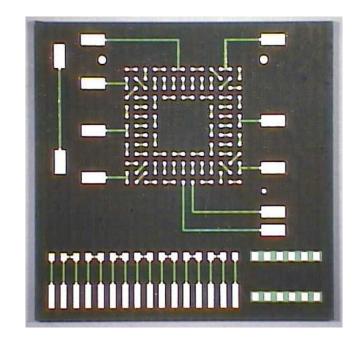
- Plating area 15%
- Metal running cost includes processing charge

Deposit Thickness (µm)	ENEPIG	E'lytic Ni/Au	ENEG
Gold	0.03	0.5	0.5
Palladium	0.1	-	-

ENEPIG – Raytheon Reliability Study

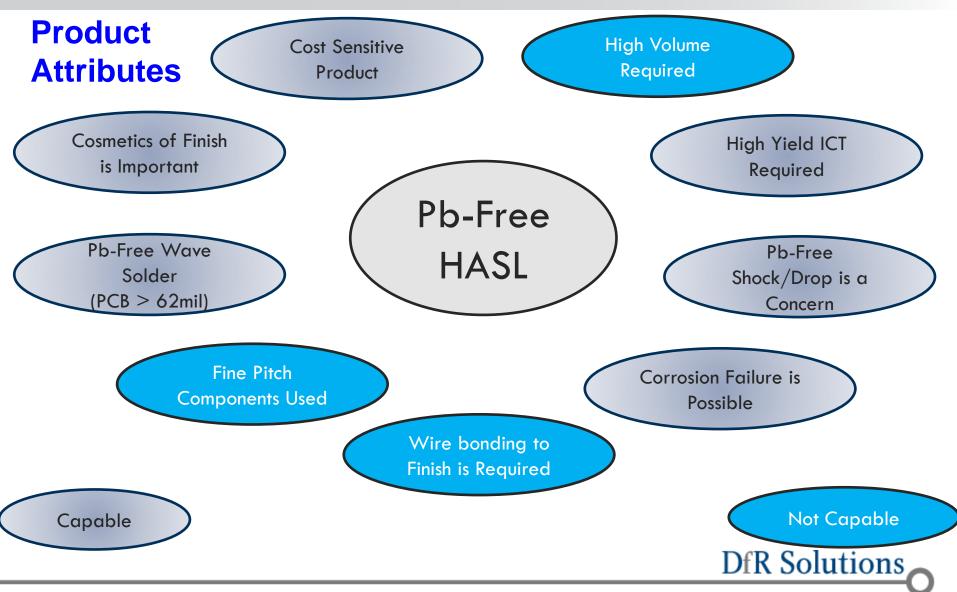
• ENEPIG Reliability Conclusions

- Visual, Functional, X-Ray and Shear Tests All Passed
- Trace Durability Tests Passed
- Pd Thickness Had No Effect on Wire Bond Results
- Suppliers, Designs and Applications Outside the Scope of the Work Seek Further Validation
- ENEPIG Has Potential as a Viable Low Cost Board Finish for Wire Bonding and Sn63 Soldering





Surface Finish Selection Guideline



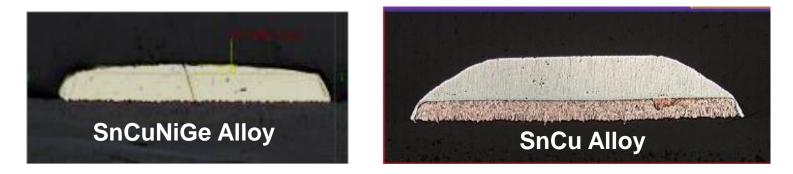
Solderability Plating: Pb-Free HASL

- Increasing Pb-free solderability plating of choice
- Primary material is Ni-modified SnCu (SN100CL)
 - Initial installations of SAC being replaced
 - Only Vicor recently identified as using SAC HASL (Electronic Design, Nov 2007)
 - Co-modified SnCu also being offered (claim of 80 installations [Metallic Resources])
- Selection driven by
 - Storage
 - Reliability
 - Solderability
 - Planarity
 - Copper Dissolution



Pb-Free HASL: Ni-modified SnCu

- Alloy selection is critical.
 - Sn-Cu will result in high Cu dissolution and poor planarity.
 - SnCuNiGe provides high fluidity and reduced Cu dissolution.



• Role of constituents

- Cu creates a eutectic alloy with lower melt temp (227C vs. 232C), forms intermetallics for strength, and reduces copper dissolution
- $_{\circ}$ Ni suppresses formation of $\beta\mbox{-Sn}$ dendrites, controls intermetallic growth, grain refiner

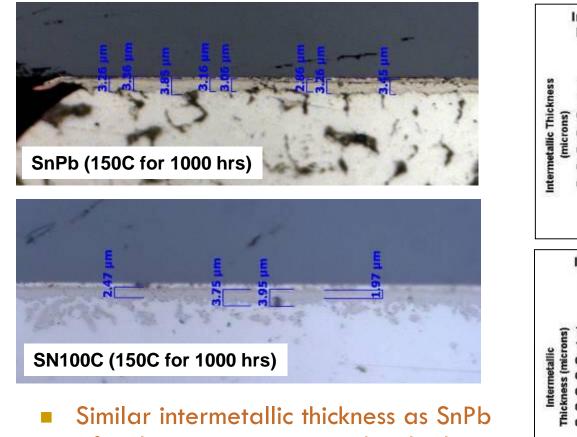
DfR Solutions

• **Ge** prevents oxide formation (dross inhibitor), grain refiner

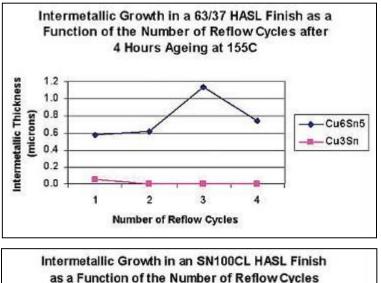
Pb-free HASL: Storage

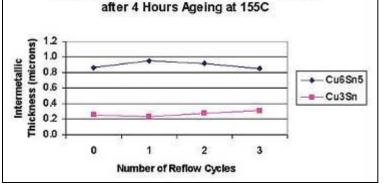
- PCBs with SnPb HASL have storage times of 1 to 4 years
 - Driven by intermetallic growth and oxide formation
- SN100CL demonstrates similar behavior
 - Intermetallic growth is suppressed through Ni-addition
 - Oxide formation process is dominated by Sn element (similar to SnPb)
- Limited storage times for alternative Pb-free platings (OSP, Immersion Tin, Immersion Silver)

Pb-Free HASL: Intermetallic Growth



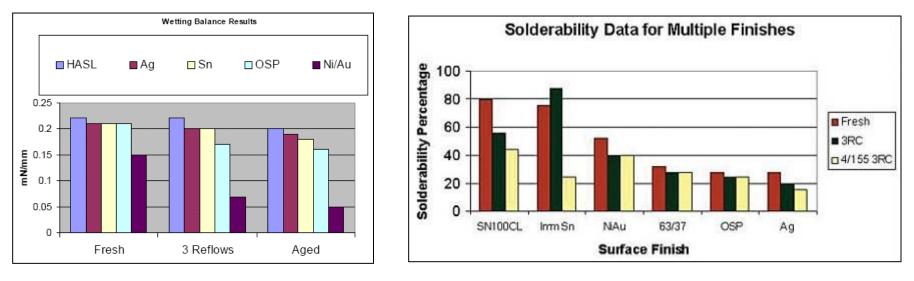
Similar intermetallic thickness as SnPb after long-term aging and multiple reflows





HASL and Flow: A Lead-Free Alternative, T. Lentz, et. al., Circuitree, Feb 2008, http://www.circuitree.com/Articles/Feature_Article/BNP_GUID_9-5-2006_A_10000000000243033

Industry adage: Nothing solders like solder



- Discussions with CMs and OEMs seem to indicate satisfaction with Pb-free HASL performance
 - Additional independent, quantitative data should be gathered
- Improved solderability could improve hole fill

http://www.daleba.co.uk/download%20section%20-%20lead%20free.pdf

HASL and Flow: A Lead-Free Alternative, T. Lentz, et. al., Circuitree, Feb 2008, http://www.circuitree.com/Articles/Feature_Article/BNP_GUID_9-5-2006_A_10000000000243033 DfR Solutions

Pb-Free HASL: Planarity

• Recommended minimum thickness

- 100 uin (4 microns)
- Lower minimums can result in exposed intermetallic

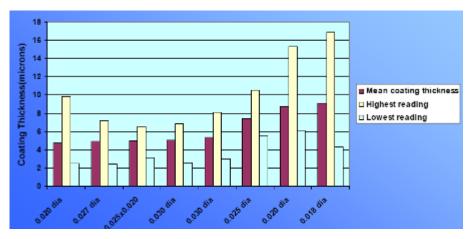
• Primary issue is thickness variability

- Greatest variation is among different pad designs
- 100 uin over small pads (BGA bond pads); over 1000 uin over large pads
- Can be controlled through air knife pressure, pot temperatures, and nickel content

Fluidity of SN100CL ensure a smooth even HASL coating

3-dimensional plot of XRF thickness scans on 1mm square pads

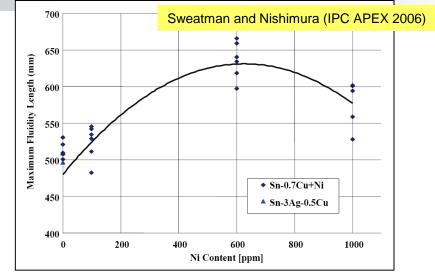
4um





Pb-Free HASL: Planarity (cont.)

- Air knives
 - Pb-free HASL requires lower air pressure to blow off excess solder
- Pot Temperatures
 - □ SnPb: 240C to 260C



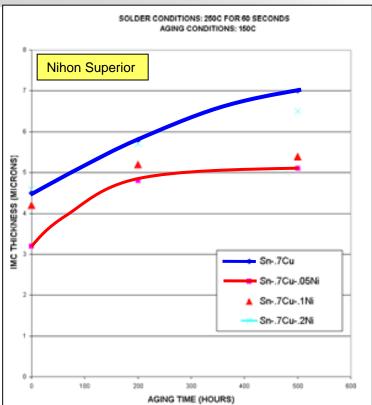
□ SN100CL: 255C to 270C (air knife temp of 280C)

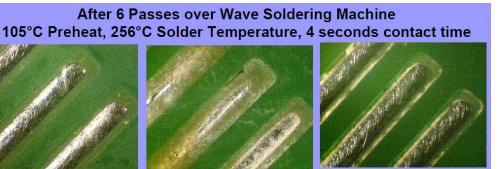
Ni content

- Variation can influence fluidity
 - Minimum levels critical for planarity
- Some miscommunication as to critical concentrations

Pb-Free HASL: Copper Dissolution

- Presence of nickel is believed to slow the copper dissolution process
 - SAC HASL removes ~ 5 um
 - □ SNC HASL removes ~1 um





Sn-3.0Ag-0.5Cu

Sn-37Pb

Sn-0.7Cu+Ni

www.p-m-services.co.uk/rohs2007.htm www.pb-free.org/02_G.Sikorcin.pdf

www.evertig.com/news/read.do?news=3013&cat=8 (Conny Thomasson, Candor Sweden AB)



Pb-Free HASL: Additional Concerns

- Risk of thermal damage, including warpage and influence on long term reliability (PTH fatigue, CAF robustness)
 - No incidents of cracking / delamination / excessive warpage reported to DfR to date
 - Short exposure time (3 to 5 seconds) and minimal temp. differential (+5°C above SnPb) may limit this effect
- Compatibility with thick (>0.135") boards
 - Limited experimental data (these products are not currently Pb-free)
- Mixing of SNC with SAC
 Initial testing indicates no long-term reliability issues (JGPP)

LF HASL – Critical Parameters

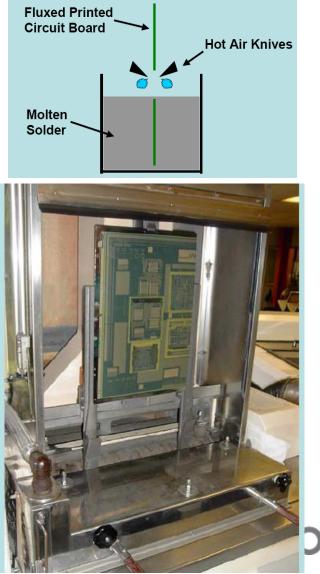
Pre-Clean:

- Micro-etching rate
- Flux

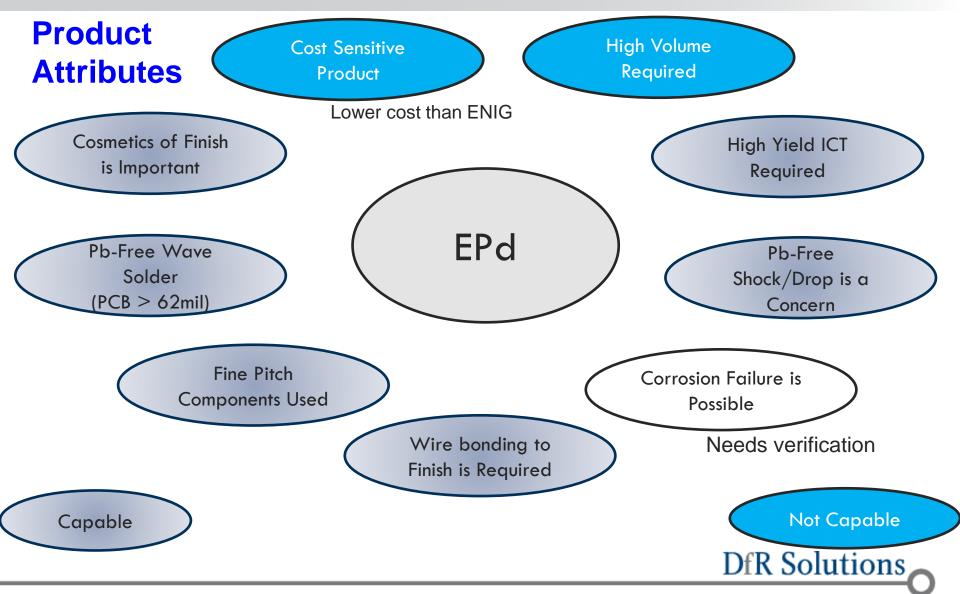
HASL:

- LF Alloy
- Pot temperature ($\sim 265C$)
- Front & Back air knife pressure
- Front & Back air knife angle
- Distance between air knife & PCB
- Lifting speed
- Dwell time (~ 2-4 sec)
- Post-Clean:
- Final flux clean and rinsing

THE BASIC VERTICAL PROCESS

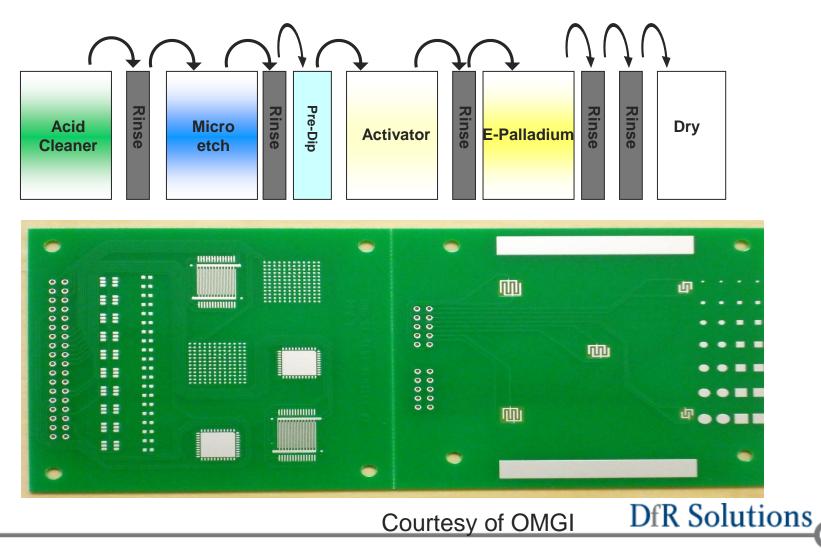


Newer Finishes to the Market

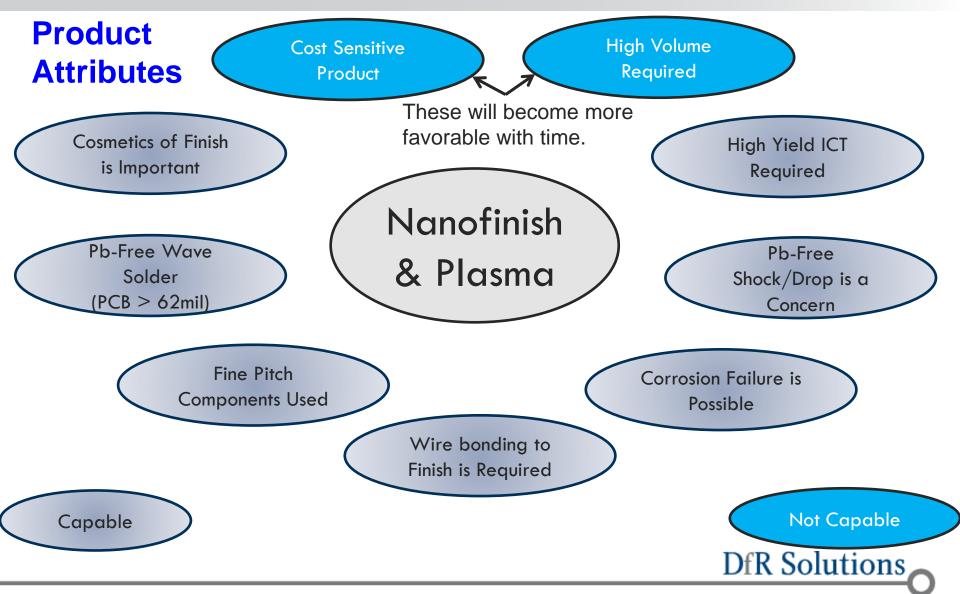


Electroless Pd

Process Sequence



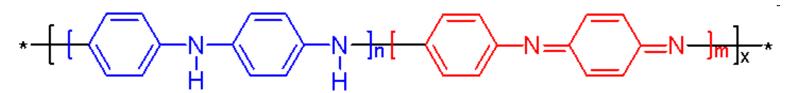
Newer Finishes to the Market



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What is Nanofinish?

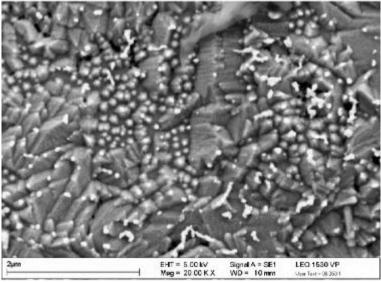
- Nanofinish was released by Ormecon in 2007 (purchased by Enthone in 2008)
 - □ After 5 to 10 years of research
 - Currently used in structural applications (e.g., iron)
- Nanofinish is described as an organic nanometal
 - Consists of a conductive polymer (polyaniline) complexed with nanoparticles of silver
 - □ Total thickness is 50 nm; silver particles are nominally 4 nm



Chemical structure of polyaniline (PNI or PANI)

How does Nanofinish work?

- The process of passivation is different from other surface finishes
 - Finish is preferentially deposited on the grain boundaries



- Grain boundaries are high energy area most prone to oxidation
 - Conduction helps passivate copper by lowering the energy levels



Why Nanofinish?

- Similar advantages to OSP
 - Bonding is to copper (stronger than bonding to nickel)
 - □ Few number of process steps

ACL 7002 Cleaner (2 min) MET 7002 Etch (2 min) DI-Rinse CND 7200 Predip (60 s) OMN 7200 Nanofinish (90 s) DI-Rinse Drying

- Some advantages over OSP
 - Conductivity is better for in-circuit testing
 - Supposedly superior performance in regards to number of reflows (>10) and long-term aging

Market for Nanofinish

- Lots of interest; still limited penetration
- Largest users or most receptive were in Asia (Korea, China) and some in Germany
- Market strategy was directed at OEMs



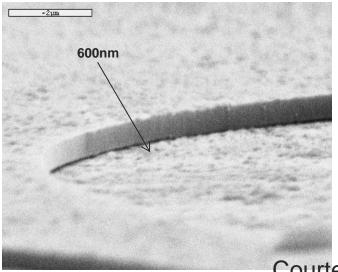
Assessment of Nanofinish

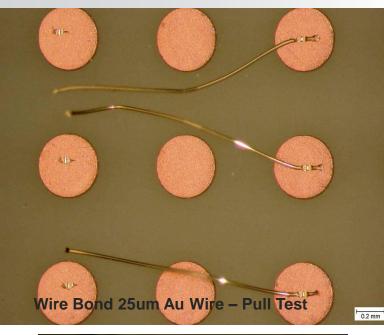
- Must consider material set
 - Conductive polymers are known to be sensitive to moisture
 - □ Silver is known to be reactive with sulfur
- Test coupon must be similar to board design
 - Through holes
 - Solder mask
 - Similar feature sizes

 Testing should go beyond steam aging and mixed flowing gas (MFG)

Plasma Coated Finish

- Coated in plasma chamber.
- Many panels coated simultaneously.
- Film is 60 nm thick.
- Flux breaks through film at elevated temperature.
- Hydrophobic and acid resistant







Courtesy of Semblant

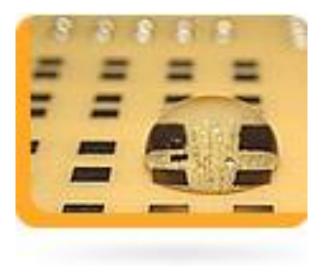
9000 Virginia Manor Rd Ste 290, Beltsville MD 20705 | 301-474-0607 | www.dfrsolutions.com

Semblant

 Utilizes plasma polymerization to deposit an ultrathin protective coating on the surface of a PCB

Extremely hydrophobic

- Extended PCB shelf life
 - Long term protection against oxidation
 - Corrosion resistance



- Acceptable solderability
 - Compatible with SnPb and Pb-free reflow processes



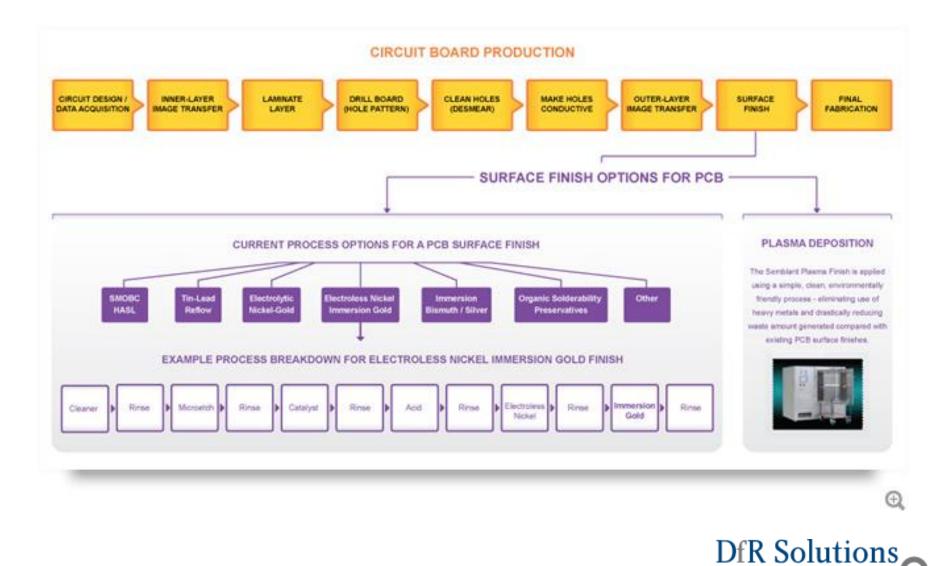
Plasma Polymerization

- Deposited using a plasma polymerization process in a vacuum chamber.
 - □ Ionizing a precursor gas in a low pressure, low temperature plasma
 - □ The process creates a dense, highly crosslinked polymer coating
- Because the coating is deposited uniformly wherever the process gas contacts the substrate, the process can deposit continuous film at coating thicknesses as low as 15nm.
 - Types of polymers that can be deposited using plasma polymerization includes a range of functional materials
 - Properties of the coatings can be tuned by selection of the precursor gas and control of the operating parameters of the process

Plasma Polymerization Process

- Precursor gas is introduced to the vacuum chamber containing the printed circuit board panels.
- RF generator sparks the plasma which ionizes and fragments the gas molecules in a glow discharge.
- Active molecular fragments can then recombine on the surface of the circuit board panels to create a thin film.
- The polymer structures that can be created in a plasma polymerization are unique to this process

Plating vs. Plasma Process



Semblant Plasma Finish

- Uses a fluoropolymer coating in a room temperature process.
 - □ The plasma deposition is combined with a pre-cleaning step
- Creates a continuous film that is 10's of nanometers thick everywhere the active gas plasma comes into contact with the surface – including through vias.
- The SPF fluoropolymer has stable chemical properties
 Resistant to heat (up to 40 minutes at 260C)
 - Resistant to chemicals (non-reactive to flux at room temp)

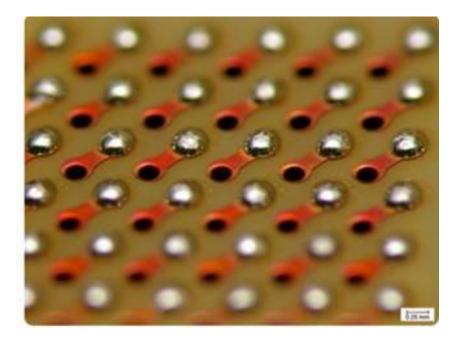
Semblant Finish (cont.)

- The Semblant fluoropolymer is removed by the combined action of the acidic flux and the high temperatures used during reflow, resulting in a direct Cu/Sn solder joint.
 - The unoxidized copper beneath the SPF coating ensures wettability of the solder.
 - The surrounding fluoropolymer film prevents the solder from spreading beyond the printed area, reducing bridging and enabling ultra-fine pitch assembly.



Plasma Finish - Advantages

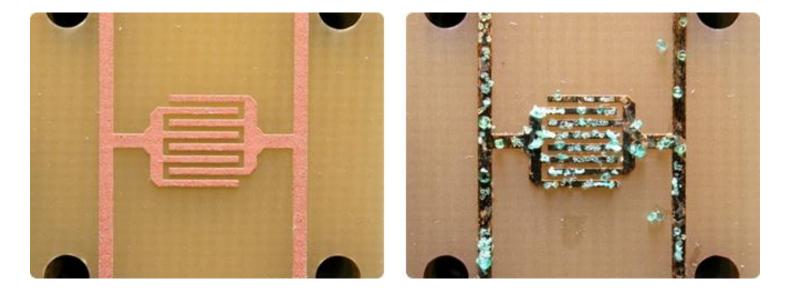
Solder mask and solderability plating in one





Advantages (cont.)

- Protection against corrosive gases
 - Actively repelling water and preventing corrosive gasses from coming into contact with the copper surface.



Plasma coating vs. ENIG (elevated sulfur gas testing



Challenges

- Will require redesign of stencils and optimization of some manufacturing processes
 - No flux? No wetting
 - Can not rely on solder alone



Examples of Best Application Fits

- OSP (but must address ICT issues)
 - Hand held electronics
 - Notebook computers
 - Basic desktop computers
 - Basic consumer electronics & power supplies
 - Simple Pb-free Medical or aerospace (thin PCBs)

• ENIG or ENEPIG

- SnPb medical and aerospace
- Pb-free that is not susceptible to shock



Examples of Best Fits

- o ImAg
 - Fully enclosed hand held electronics
 - Basic consumer electronics low power and airflow
- ImSn
 - Simple consumer electronics (not fully enclosed)
 - Simple medical or aerospace applications (1 side)
 - Low to moderate volume peripheral components
- LF HASL
 - Thick LF PCBs going into business environments (servers, telecom equipment)

DfR Solutions

o Complex Pb-Free medical or aerospace?

What to do if there is no SF fit?

- If no SF fits your specific requirements, design modifications may be required and tradeoffs made.
- For example, I need low cost, high volume, corrosion resistant, with good ICT capability.
 - One solution might be to use ImAg but plug the vias with soldermask to protect from corrosion (but some cost is sacrificed).
 - Another is to use OSP but implement cleaning to remove flux residue for probing (cost is again sacrificed).

Example #2

- Another example might be the desire to use ENIG for a Pb-free product where shock is a concern.
 - One solution might be to underfill critical components sensitive to shock (cost adder).
 - Another might be to dampen the shock by better design of the enclosure (possible cost adder).

Summary

- The surface finish you select will have a large influence on quality, reliability and cost.
- It is a complex decision that impacts many areas of the business.
- Select a finish that optimal for the business (and not just one function).
- Know that there are engineering tricks to improve on weak areas of each finish.
- Stay current in this field because new developments continue to be made.

Contact Information

- Questions?
 - Contact Cheryl Tulkoff, ctulkoff@dfrsolutions.com, 512-913-8624
 - www.dfrsolutions.com
- Connect with me in LinkedIn as well!

Speaker Biography

- Cheryl Tulkoff has over 22 years of experience in electronics manufacturing with an emphasis on failure analysis and reliability. She has worked throughout the electronics manufacturing life cycle beginning with semiconductor fabrication processes, into printed circuit board fabrication and assembly, through functional and reliability testing, and culminating in the analysis and evaluation of field returns. She has also managed no clean and RoHS-compliant conversion programs and has developed and managed comprehensive reliability programs.
- Cheryl earned her Bachelor of Mechanical Engineering degree from Georgia Tech. She is a published author, experienced public speaker and trainer and a Senior member of both ASQ and IEEE. She has held leadership positions in the IEEE Central Texas Chapter, IEEE WIE (Women In Engineering), and IEEE ASTR (Accelerated Stress Testing and Reliability) sections. She chaired the annual IEEE ASTR workshop for four years, is an ASQ Certified Reliability Engineer and a member of SMTA and iMAPS.
- She has a strong passion for pre-college STEM (Science, Technology, Engineering, and Math) outreach and volunteers with several organizations that specialize in encouraging pre-college students to pursue careers in these fields.





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Best Regards, Dr. Craig Hillman, CEO

